

# 8-channel High Voltage analog switch IC

## ECN3290TF Product Specification

### 1. General Description

#### 1.1 General

ECN3290 is an 8-channel High Voltage analog switching IC on which latch-up free is realized by dielectric isolation technology.

High voltage and low on-resistance MOS switches are used as output devices controlled by a 5.0V signal. The ECN3290 is most suited to ultrasound imaging applications.

#### 1.2 Functions and Features

- \* High voltage and low on-resistance MOS switches integrated.
- \* 8bit shift register integrated.
- \* Switch on-resistance: 22 Ω typ. ( VPP=100V,VNN=-100V,ISIG=5mA, 25°C)
- \* Switch breakdown voltage: 220V
- \* Power up/down sequence of power supply is free.
- \* 48-pin LQFP Package. (RoHS compliant)

#### 1.3 Block diagram

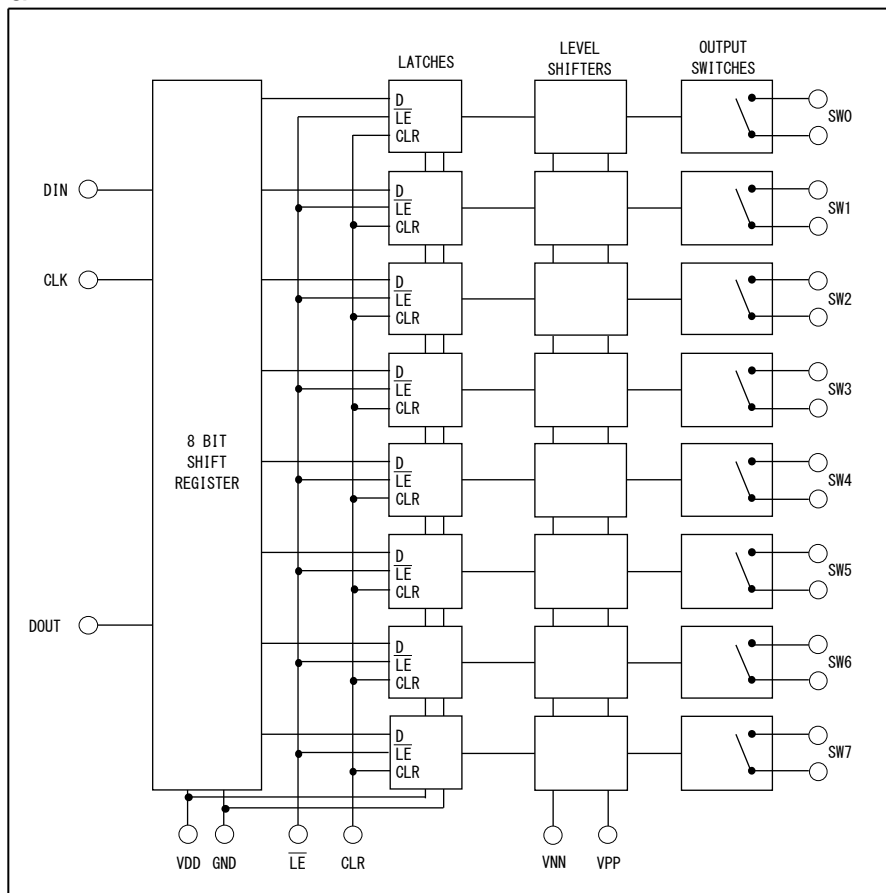


Fig. 1.3.1 Block diagram

## 2. Specifications

## 2.1 Absolute Maximum Ratings

Table 2.1.1 Absolute Maximum Ratings

No.	Items	Symbol	Terminal	Values	Unit	Note
1	Logic power supply voltage	VDD	VDD	-0.5 ~ +7.0	V	Ta=25°C
2	VPP-VNN supply voltage	-	VPP, VNN	220	V	Ta=25°C
3	VPP Positive high voltage supply	VPP	VPP	-0.5 to VNN+200	V	Ta=25°C
4	VNN negative high voltage supply	VNN	VNN	-200 to +0.5	V	Ta=25°C
5	Logic input voltages	-	DIN, CLK, CL, <u>LE</u>	-0.5 to VDD+0.3	V	Ta=25°C
6	Analog signal range	-	SW0 to SW7	VNN to VPP	V	Ta=25°C
7	Operating junction temperature	Tjop	-	-20 to +125	°C	
8	Storage temperature	Tstg	-	-65 to +150	°C	
9	Power dissipation	Pw	-	1.0	W	Ta=70°C

## 2.2 Electrical Characteristics

### 2.2.1 DC Characteristics

Table 2.2.1 DC Characteristics

Ta=25°C VDD=5.0V

No.	Items	Symbol	Spec			Unit	Test conditions	
			Min	Typ	Max			
1	Small signal switch on resistance	RONS	-	26	38	Ω	ISIG=5mA	VPP=40V, VNN=-160V
			-	22	27		ISIG=200mA	VNN=-160V
			-	22	27		ISIG=5mA	VPP=100V, VNN=-100V
			-	18	24		ISIG=200mA	VNN=-100V
			-	20	25		ISIG=5mA	VPP=160V, VNN=-40V
			-	16	25		ISIG=200mA	VNN=-40V
2	Small signal switch on resistance matching	ΔRONS	-	5	20	%	VPP=100V, VNN=-100V ISIG=5mA	
3	Large signal switch on resistance	RONL	-	20	-	Ω	VPP=100V VNN=-100V	ISIG =1A
4	Switch off leakage per switch	ISOL	-	1.0	10	μA	VSIG=VPP-10V, or VNN+10V	
5	DC offset switch (off)	DCOFF	-	10	100	mV	RL=100kΩ	
6	DC offset switch (on)	DCON	-	10	100	mV	RL=100kΩ	
7	Positive HV supply current	IPPQ1	-	10	50	μA	All SWs off	
8	Negative HV supply current	INNQ1	-	-10	-50	μA	All SWs off	
9	Positive HV supply current	IPPQ2	-	10	50	μA	All SWs on, ISIG=5mA	
10	Negative HV supply current	INNQ2	-	-10	-50	μA	All SWs on, ISIG=5mA	
11	IPP Supply current	IPP	-	-	7.0	mA	VPP=40V VNN=-160V	fSW=50kHz no-load
			-	-	5.0		VPP=100V VNN=-100V	
			-	-	5.0		VPP=160V VNN=-40V	
12	INN Supply current	INN	-	-	7.0	mA	VPP=40V VNN=-160V	fSW=50kHz no-load
			-	-	5.0		VPP=100V VNN=-100V	
			-	-	5.0		VPP=160V VNN=-40V	
13	Logic supply average current	IDD	-	-	4.0	mA	fCLK=5MHz	
14	Logic supply quiescent current	IDDQ	-	-	10	μA		
15	Data out source current	ISOR	0.45	0.70	-	mA	Vdout=VDD-0.7V	
16	Data out sink current	ISINK	0.45	0.70	-	mA	Vdout=0.7V	

### 2.2.2 AC Characteristics

Table 2.2.2 AC Characteristics

Ta=25°C VDD=5.0V

No.	Items	Symbol	Spec			Unit	Test conditions
			Min	Typ	Max		
1	SW Turn on time	tON	-	-	5.0	μs	VSIG=VPP-10V, RL=10kΩ
2	SW Turn off time	tOFF	-	-	5.0	μs	VSIG=VPP-10V, RL=10kΩ
3	Clock frequency	fCLK	-	-	10	MHz	50% duty cycle, fDIN=fCLK/2
4	Clock delay time to data out	tDO	30	-	85	ns	DOUT terminal
5	Output voltage spike	+VSPK	-	-	150	mV	VPP=40V, VNN=-160V, RL=50Ω
		-VSPK	-	-	-200		
		+VSPK	-	-	150		VPP=100V, VNN=-100V, RL=50Ω
		-VSPK	-	-	-200		
		+VSPK	-	-	150		VPP=160V, VNN=-40V, RL=50Ω
		-VSPK	-	-	-200		

### 2.2.3 AC Characteristics (for reference purpose only)

These items are not tested when shipped.

Table 2.2.3 AC Characteristics (for reference purpose only)

Ta=25°C VDD=5.0V

No.	Items	Symbol	Spec			Unit	Condition
			Min	Typ	Max		
1	Off capacitance SW to GND	CSG (off)	-	9	-	pF	Measurement signal (DC 0V, AC 1MHz)
2	On Capacitance SW to GND	CSG (on)	-	14	-	pF	Measurement signal (DC 0V, AC 1MHz)
3	SW off isolation	KO	-30	-33	-	dB	f=5MHz, RL=1kΩ//15pF
			-54	-60	-	dB	f=5MHz, RL=50Ω
4	SW crosstalk	KCR	-54	-60	-	dB	f=5MHz, RL=50Ω

### 3. Recommended Operating Conditions

Please operate in use within the limit of recommended operating conditions detailed in Table 3.1.

Table 3.1 Recommended Operating Conditions

No	Items	Symbol	Recommended Value	Unit	Condition
1	Logic power supply voltage	VDD	4.5 to 5.5	V	
2	Positive high voltage supply	VPP	40 to VNN+200	V	
3	Negative high voltage supply	VNN	-160 to -40	V	
4	High-level input voltage	VIH	VDD-1.5 to VDD	V	
5	Low-level input voltage	VIL	0 to 1.5VDD	V	
6	Analog signal voltage peak to peak	VSIG	VNN+10 to VPP-10	V	
7	Operating free air-temperature	Ta	0 to 70	°C	
8	Switching frequency	fSW	50 max	kHz	Duty Cycle=50%
9	Set up time for $\overline{LE}$	tSD	Min.75	ns	
10	Pulse width of $\overline{LE}$	tWLE	Min.75	ns	
11	Time width of CL	tWCL	Min.60	ns	
12	Set up time DATA to Clock	tSU	Min.10	ns	
13	Hold time DATA from Clock	th	Min.20	ns	
14	Maximum VSIG Slew Rate	dV/dt	Max.30	V/ ns	

Attention ;

- 1) Power up/down sequence of power supply is arbitrary except GND terminal of IC must be powered-up first and powered-down last.
- 2) It is indispensable to make there are not to exceed a maximum rated voltage by the occurrence of the excessive voltage in case of power-on and power-off of the power supply.

4. Test Circuit

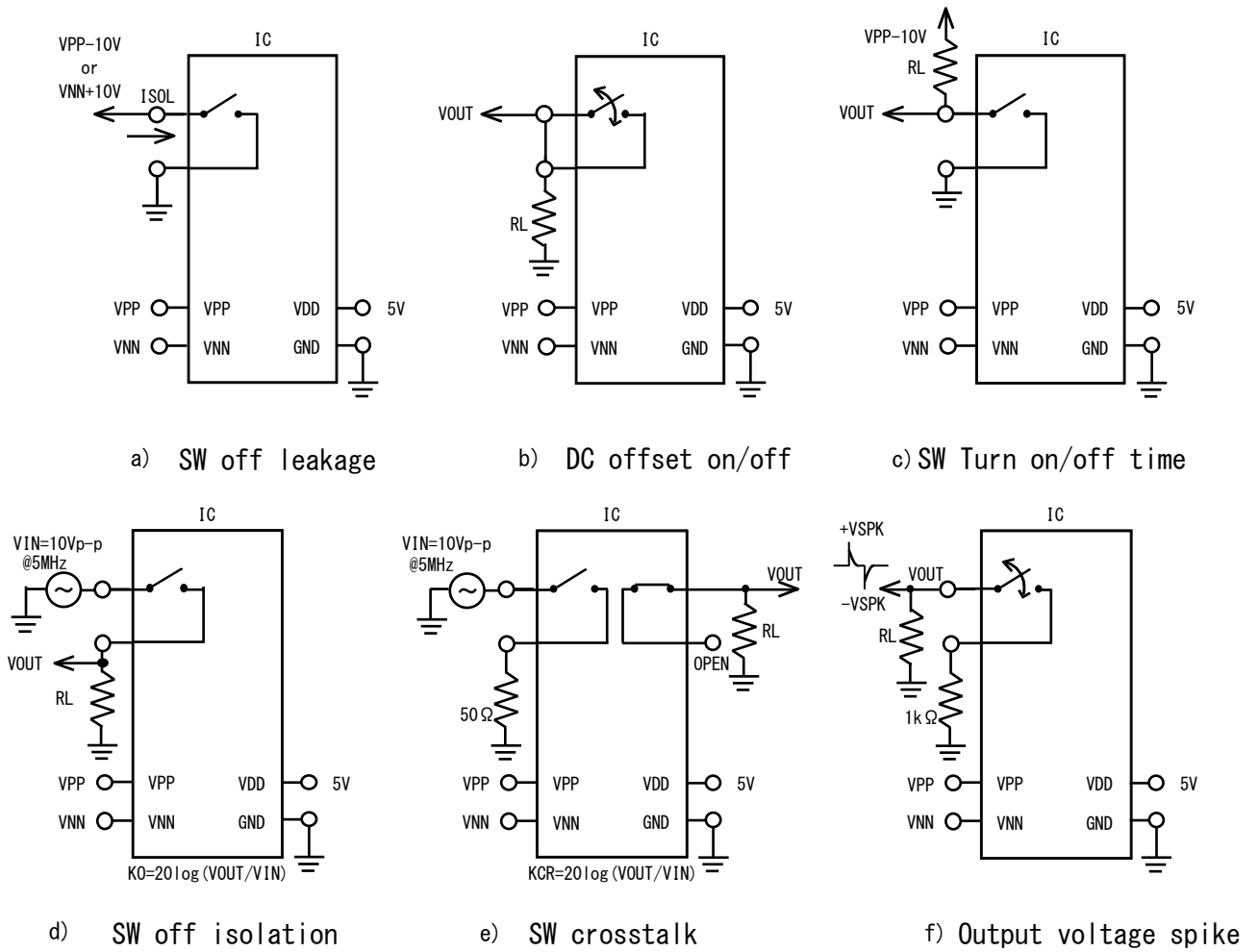


Fig. 4.1 Test Circuit

5. Timing Waveforms

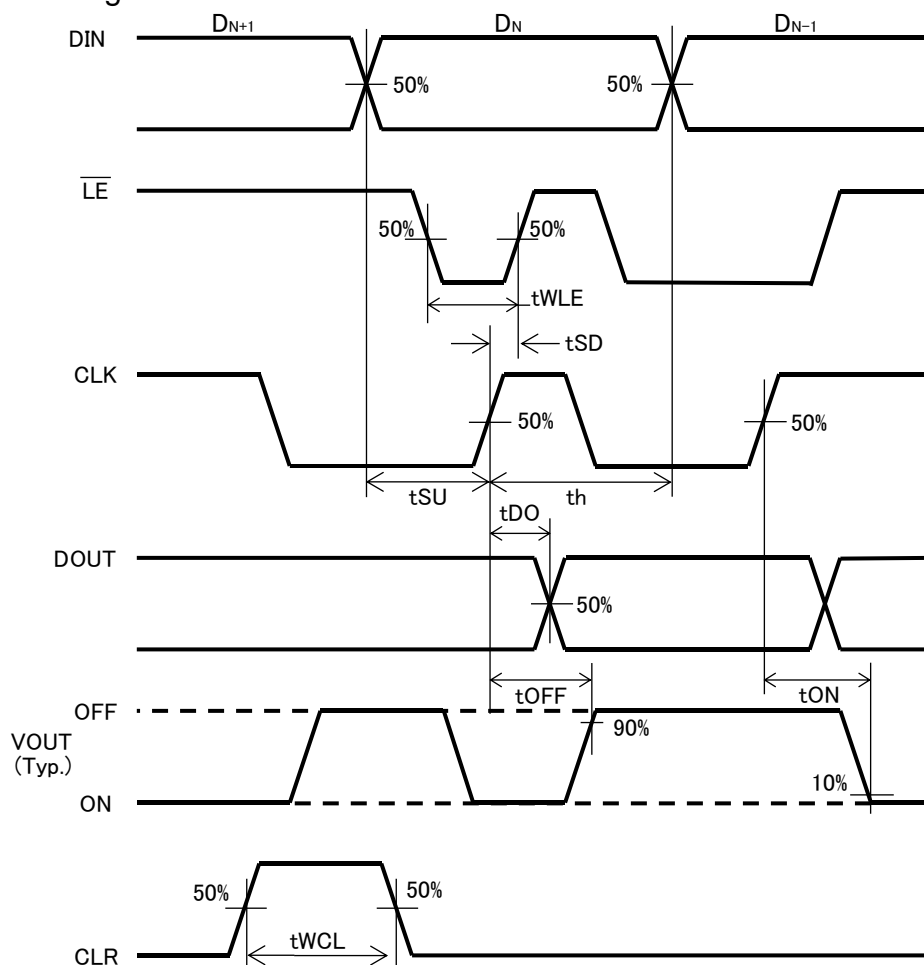


Fig. 5.1 Timing Waveforms

Note

1. Serial data is clocked in on the rising edge of CLK.
2. The switches go to a state retaining their present condition on the rising edge of  $\overline{LE}$ .

### 6. Truth Table

Table 6.1 Truth table

D0	D1	D2	D3	D4	D5	D6	D7	$\overline{LE}$	CLR	SW0	SW1	SW2	SW3	SW4	SW5	SW6	SW7
L								L	L	OFF							
H								L	L	ON							
	L							L	L		OFF						
	H							L	L		ON						
		L						L	L			OFF					
		H						L	L			ON					
			L					L	L				OFF				
			H					L	L				ON				
				L				L	L					OFF			
				H				L	L					ON			
					L			L	L						OFF		
					H			L	L						ON		
						L		L	L							OFF	
						H		L	L							ON	
							L	L	L								OFF
							H	L	L								ON
X	X	X	X	X	X	X	X	H	L	HOLD PREVIOUS STATE							
X	X	X	X	X	X	X	X	X	H	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF

X = Don't care

Note

1. The 8 Switches operate independently.
2. When  $\overline{LE}$  is low, the shift register data flows through the latch.
3. Shift register clocking has no effect on the switch states if  $\overline{LE}$  is high.
4. When switch 7 is ON, DOUT is high.
5. The clear input overrides all other inputs.



## 7. Pin Function

ECN3290TF TQFP48 (48Pin TQFP)

Table 7.1. Pin Function

Pin	Name	Functions	Note
1	SW5	Analog Switch 5	
2	N/C	No connection	*1
3	SW4	Analog Switch 4	
4	N/C	No connection	*1
5	SW4	Analog Switch 4	
6	N/C	No connection	*1
7	N/C	No connection	*1
8	SW3	Analog Switch 3	
9	N/C	No connection	*1
10	SW3	Analog Switch 3	
11	N/C	No connection	*1
12	SW2	Analog Switch 2	
13	N/C	No connection	*1
14	SW2	Analog Switch 2	
15	N/C	No connection	*1
16	SW1	Analog Switch 1	
17	N/C	No connection	*1
18	SW1	Analog Switch 1	
19	N/C	No connection	*1
20	SW0	Analog Switch 0	
21	N/C	No connection	*1
22	SW0	Analog Switch 0	
23	N/C	No connection	*1
24	VPP	Positive High Voltage Supply	*2
25	VNN	Negative High Voltage Supply	*2
26	N/C	No connection	*1
27	N/C	No connection	*1
28	GND	Ground	
29	VDD	Logic Supply Voltage	
30	N/C	No connection	*1
31	N/C	No connection	*1
32	N/C	No connection	*1
33	DIN	Serial Data Input	
34	CLK	Serial Clock Input	
35	LE	Latch-Enable Input	
36	CLR	Latch-Clear Input	
37	DOUT	Serial Data Output	
38	N/C	No connection	*1
39	SW7	Analog Switch 7	
40	N/C	No connection	*1
41	SW7	Analog Switch 7	
42	N/C	No connection	*1
43	SW6	Analog Switch 6	
44	N/C	No connection	*1
45	SW6	Analog Switch 6	
46	N/C	No connection	*1
47	SW5	Analog Switch 5	
48	N/C	No connection	*1

Note

1. NOT connected on chip internal.
2. High voltage supply.

8. Pin configuration

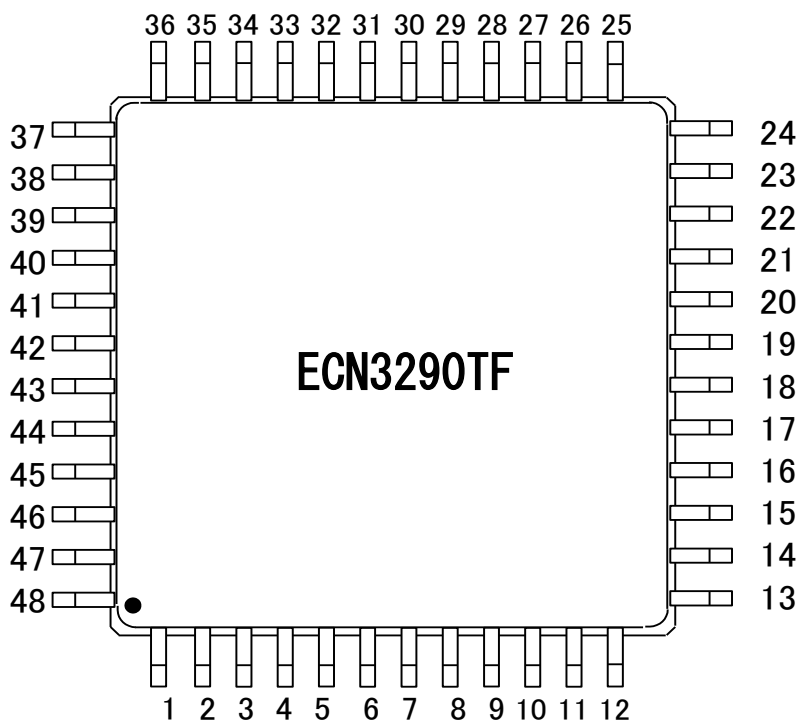


Fig. 8.1 Pin configuration(Top view)

## 9. Inspection

Hundred percent inspections shall be conducted on electric characteristics.

## 10. Precautions for use

### 10.1 Countermeasures against Electrostatic Discharge (ESD)

- (a) Customers need to take precautions to protect ICs from electrostatic discharge (ESD). The material of the container or any other device used to carry ICs should be free from ESD, which can be caused by vibration during transportation. Use of electrically conductive containers is recommended as an effective countermeasure.
- (b) Everything that touches ICs, such as the work platform, machine, measuring equipment, and test equipment, should be grounded.
- (c) Workers should be high-impedance grounded (100kΩ to 1MΩ) while working with ICs, to avoid damaging the ICs by ESD.
- (d) Friction with other materials, such as high polymers, should be avoided.
- (e) When carrying a PCB with a mounted IC, ensure that the electric potential is maintained at a constant level using the short-circuit terminals and that there is no vibration or friction.
- (f) The humidity at an assembly line where ICs are mounted on circuit boards should be kept around 45 to 75 percent using humidifiers or such. If the humidity cannot be controlled effectively, using ionized air blowers (ionizers) is effective.

### 10.2 Output Short-circuit Protection

This IC (the product of Hitachi Power Semiconductor Device, hereinafter called "HPSD's IC") could break by a short circuit (ex. load short). Therefore, external protection is needed.

### 10.3 Maximum Ratings

Regardless of changes in external conditions during use of HPSD's IC, the "maximum ratings" described in this document should never be exceeded when designing electronic circuits that employ HPSD's IC. If maximum ratings are exceeded, HPSD's IC may be damaged or destroyed. In no event shall Hitachi Power Semiconductor Device (hereinafter called "HPSD") be liable for any failure in HPSD's IC or any secondary damage resulting from use at a value exceeding the maximum ratings.

### 10.4 Derating Design

Continuous high-load operation (high temperatures, high voltages, large currents) should be avoided and derating design should be applied, even within the ranges of the maximum ratings, to ensure reliability.

### 10.5 Safe Design

The HPSD's IC may fail due to accidents or unexpected surge voltages. Accordingly, adopt safe design features, such as redundancy and measures to prevent misuse, in order to avoid extensive damage in the event of a failure.

### 10.6 Application

If HPSD's IC is applied to the following uses where high reliability is required, obtain the document of permission from HPSD in advance.

- Automobile, Train, Vessel, etc.

Do not apply HPSD's IC to the following uses where extremely high reliability is required.

- Nuclear power control system, Aerospace instrument, Life-support-related medical equipment, etc.

### 10.7 Soldering

Lead-free solder is used for coating pins and the tab of this IC.

Refer to "Precautions for Use of High Voltage Monolithic Ics" for soldering conditions.

#### 10.8 Storage Conditions

- (1) Before opening the moisture prevention bag (aluminum laminate bag)

Temperature: less than 40°C

Humidity: less than 90%RH

Period: less than 12 months

- (2) After opening the moisture prevention bag (aluminum laminate bag)

Temperature: 5°C to 30°C

Humidity: less than 60%RH

Period: less than 168 hours

- ※ When the period of (1) and (2) is likely to expire, store the IC in a drying furnace (10%RH or lower) at ordinary temperature.

- (3) Baking process

When the period of (1) and (2) has expired, the IC should be baked in accordance with the following conditions. (However, when the IC is stored in a drying furnace (10%RH or lower) ordinary temperature, there is no need to bake.) Do not bake the tape and the reel of the taping package because they are not heat resistant. Transfer the IC to a heat resistant container prior to baking.

Temperature: 125°C to 135°C

Period: more than 48 hours

#### 10.9 Others

See "Instructions for Use of Hitachi High-Voltage Monolithic ICs" for other precautions and instructions on how to deal with these kinds of products.

## 11. Usage

- (1) HPSD warrants that the HPSD products have the specified performance according to the respective specifications at the time of its sale. Testing and other quality control techniques of the HPSD products by HPSD are utilized to the extent HPSD needs to meet the specifications described in this document. Not every device of the HPSD products is specifically tested on all parameters, except those mandated by relevant laws and/or regulations.
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◆Appendix-Supplementary Data

1. Package Outline

Units : mm

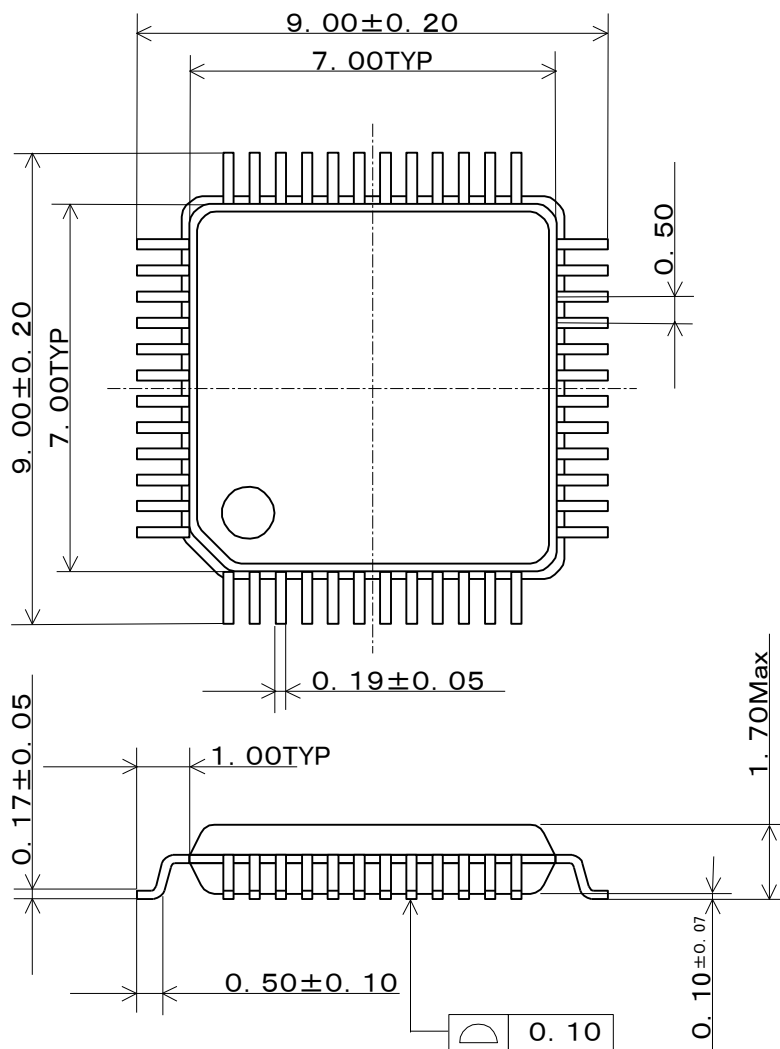


Fig.A Package outline

## 2. Marking spec

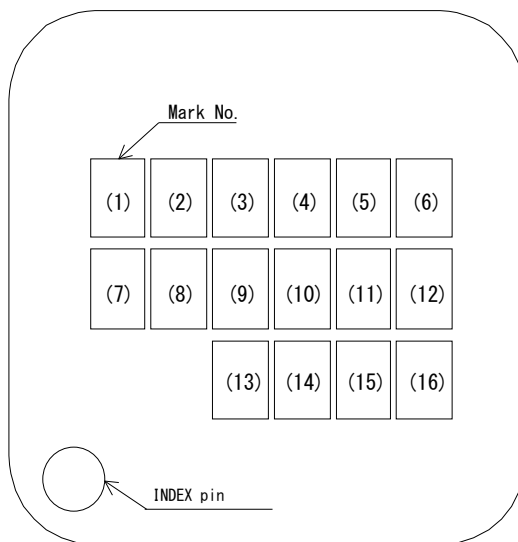


Fig.B Marking

1) No.(1) ; Blank

2) No.(2)~(6) ; Manufacturing No.

No.(2) ; Year code (Least significant digit of Assembled year (A.D.))

No.(3) ; Month code (Refer to below.)

Jan. ; A, Feb. ; B, Mar. ; C, Apr. ; D,

May ; E, June ; K, July ; L, Aug. ; M,

Sep. ; N, Oct. ; X, Nov. ; Y, Dec. ; Z

No.(4)~(6) ; Serial number

3) No.(7) ; Blank

4) No.(8)~(16) ; Product name ; ECN3290TF

3. Packing Form

Packaging details are as shown below.

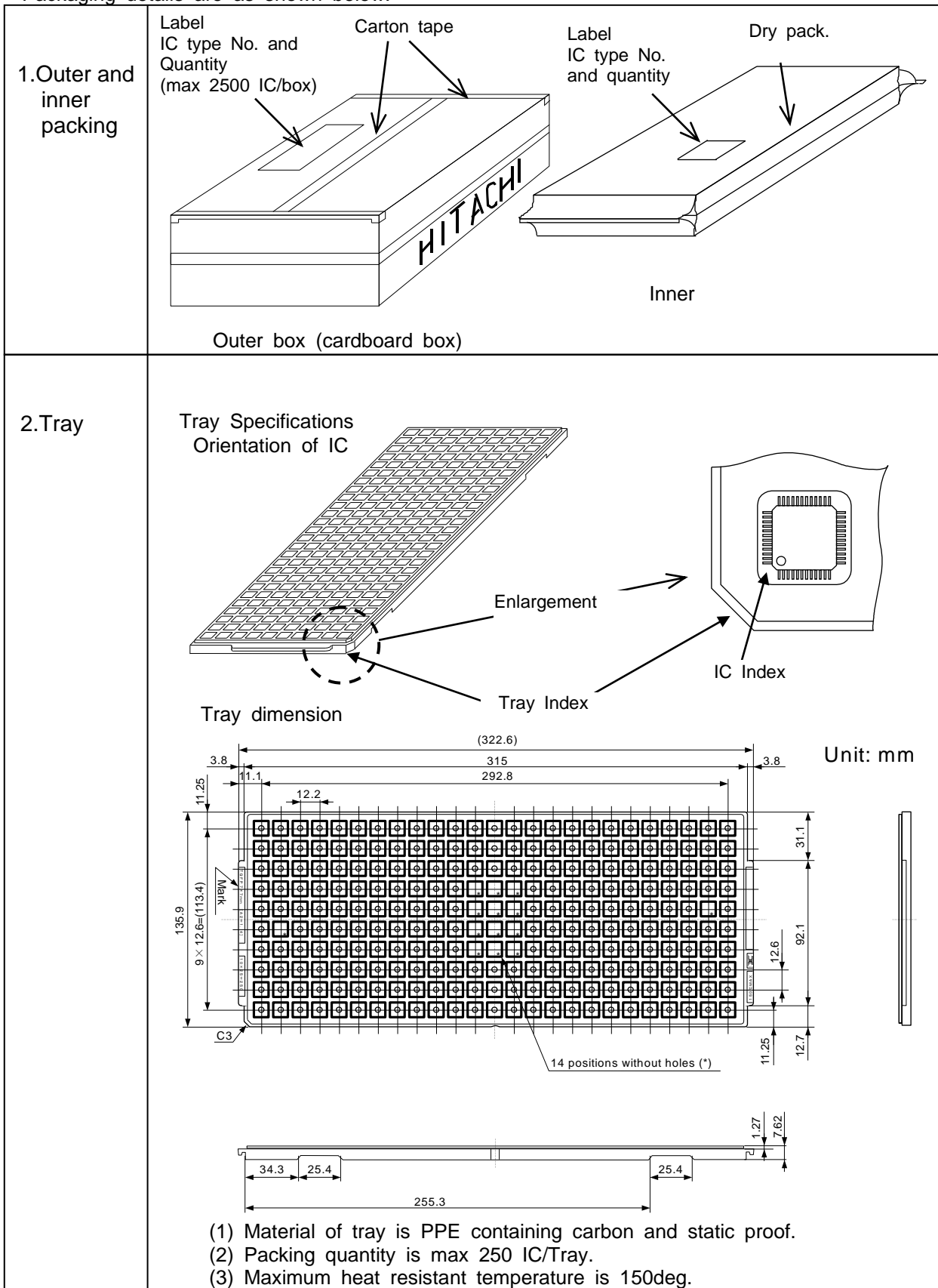


Fig.C IC packing detail



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## Precautions for Safe Use and Notices

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If semiconductor devices are handled in an inappropriate manner, failures may result. For this reason, be sure to read the latest version of "Instructions for Use of Hitachi High-Voltage Monolithic ICs" before use.



This mark indicates an item requiring caution.



### CAUTION

This mark indicates a potentially hazardous situation which, if not avoided, may result in minor or moderate injury and damage to property.



### CAUTION

- (1) Regardless of changes in external conditions during use of semiconductor devices, the "maximum ratings" and "safe operating area(SOA)" should never be exceeded when designing electronic circuits that employ semiconductor devices.
- (2) Semiconductor devices may fail due to accidents or unexpected surge voltages. Accordingly, adopt safe design features, such as redundancy and measures to prevent misuse, in order to avoid extensive damage in the event of a failure.
- (3) If semiconductor devices are applied to uses where high reliability is required, obtain the document of permission from HPSD in advance (Automobile, Train, Vessel, etc.). Do not apply semiconductor devices to uses where extremely high reliability is required (Nuclear power control system, Aerospace instrument, Life-support-related medical equipment, etc.).  
(If a semiconductor device fails, there may be cases in which the semiconductor device, wiring or wiring pattern will emit smoke or cause a fire or in which the semiconductor device will burst.)

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## NOTICES

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1. This Data Sheet contains the specifications, characteristics, etc. concerning power semiconductor products (hereinafter called "products").
2. All information included in this document such as product data, diagrams, charts, algorithms, and application circuit examples, is current as of the date this document is issued. Such information, specifications of products, etc. are subject to change without prior notice. Before purchasing or using any of the HPSD products listed in this document, please confirm the latest product information with a HPSD sales office.
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